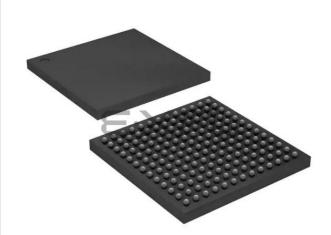
# E·XFL

#### Intel - EP4CGX15BF14C6N Datasheet



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#### Understanding <u>Embedded - FPGAs (Field</u> <u>Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

#### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### Details

Details	
Product Status	Active
Number of LABs/CLBs	900
Number of Logic Elements/Cells	14400
Total RAM Bits	552960
Number of I/O	72
Number of Gates	-
Voltage - Supply	1.16V ~ 1.24V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	169-LBGA
Supplier Device Package	169-FBGA (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/intel/ep4cgx15bf14c6n

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

Table 1–3.	Recommended Operating Conditions for Cyclone IV E Devices <sup>(1), (2</sup>	<sup>9</sup> (Part 2 of 2)
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Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I <sub>Diode</sub>	Magnitude of DC current across PCI-clamp diode when enable	_	_		10	mA

#### Notes to Table 1–3:

 Cyclone IV E 1.0 V core voltage devices only support C8L, C9L, and I8L speed grades. Cyclone IV E 1.2 V core voltage devices only support C6, C7, C8, I7, and A7 speed grades.

(2)  $V_{CCI0}$  for all I/O banks must be powered up during device operation. All vCCA pins must be powered to 2.5 V (even when PLLs are not used) and must be powered up and powered down at the same time.

(3)  $V_{CC}$  must rise monotonically.

(4) V<sub>CCI0</sub> powers all input buffers.

(5) The POR time for Standard POR ranges between 50 and 200 ms. Each individual power supply must reach the recommended operating range within 50 ms.

(6) The POR time for Fast POR ranges between 3 and 9 ms. Each individual power supply must reach the recommended operating range within 3 ms.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>ccint</sub> <i>(3)</i>	Core voltage, PCIe hard IP block, and transceiver PCS power supply		1.16	1.2	1.24	V
V <sub>CCA</sub> (1), (3)	PLL analog power supply	_	2.375	2.5	2.625	V
V <sub>CCD_PLL</sub> <i>(2)</i>	PLL digital power supply	_	1.16	1.2	1.24	V
V <sub>CCIO</sub> <i>(3), (4)</i>	I/O banks power supply for 3.3-V operation	—	3.135	3.3	3.465	V
	I/O banks power supply for 3.0-V operation	—	2.85	3	3.15	V
	I/O banks power supply for 2.5-V operation	_	2.375	2.5	2.625	V
	I/O banks power supply for 1.8-V operation	—	1.71	1.8	1.89	V
	I/O banks power supply for 1.5-V operation	—	1.425	1.5	1.575	V
	I/O banks power supply for 1.2-V operation	_	1.14	1.2	1.26	V
V <sub>CC_CLKIN</sub> (3), (5), (6)	Differential clock input pins power supply for 3.3-V operation	—	3.135	3.3	3.465	V
	Differential clock input pins power supply for 3.0-V operation	—	2.85	3	3.15	V
	Differential clock input pins power supply for 2.5-V operation	—	2.375	2.5	2.625	V
	Differential clock input pins power supply for 1.8-V operation	—	1.71	1.8	1.89	V
	Differential clock input pins power supply for 1.5-V operation	—	1.425	1.5	1.575	V
	Differential clock input pins power supply for 1.2-V operation	—	1.14	1.2	1.26	V
V <sub>CCH_GXB</sub>	Transceiver output buffer power supply	_	2.375	2.5	2.625	V

#### Table 1–4. Recommended Operating Conditions for Cyclone IV GX Devices (Part 1 of 2)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>CCA_GXB</sub>	Transceiver PMA and auxiliary power supply	_	2.375	2.5	2.625	V
V <sub>CCL_GXB</sub>	Transceiver PMA and auxiliary power supply	_	1.16	1.2	1.24	V
VI	DC input voltage	—	-0.5		3.6	V
V <sub>0</sub>	DC output voltage —		0	—	V <sub>CCIO</sub>	V
т	Operating junction temperature	For commercial use	0	—	85	°C
TJ	Operating junction temperature	For industrial use	-40		100	°C
t <sub>RAMP</sub>	Power supply ramp time	Standard power-on reset (POR) <sup>(7)</sup>	50 µs	_	50 ms	_
		Fast POR <sup>(8)</sup>	50 µs		3 ms	_
I <sub>Diode</sub>	Magnitude of DC current across PCI-clamp diode when enabled	_	_	_	10	mA

Table 1-4. Recommended Operating Conditions for Cyclone IV GX Devices (Part 2 of 2)

#### Notes to Table 1-4:

- (1) All VCCA pins must be powered to 2.5 V (even when PLLs are not used) and must be powered up and powered down at the same time.
- (2) You must connect  $V_{CCD PLL}$  to  $V_{CCINT}$  through a decoupling capacitor and ferrite bead.
- (3) Power supplies must rise monotonically.
- (4) V<sub>CCI0</sub> for all I/O banks must be powered up during device operation. Configurations pins are powered up by V<sub>CCI0</sub> of I/O Banks 3, 8, and 9 where I/O Banks 3 and 9 only support V<sub>CCI0</sub> of 1.5, 1.8, 2.5, 3.0, and 3.3 V. For fast passive parallel (FPP) configuration mode, the V<sub>CCI0</sub> level of I/O Bank 8 must be powered up to 1.5, 1.8, 2.5, 3.0, and 3.3 V.
- (5) You must set  $V_{CC_{CLKIN}}$  to 2.5 V if you use CLKIN as a high-speed serial interface (HSSI) refclk or as a DIFFCLK input.
- (6) The CLKIN pins in I/O Banks 3B and 8B can support single-ended I/O standard when the pins are used to clock left PLLs in non-transceiver applications.
- (7) The POR time for Standard POR ranges between 50 and 200 ms. V<sub>CCINT</sub>, V<sub>CCA</sub>, and V<sub>CCIO</sub> of I/O Banks 3, 8, and 9 must reach the recommended operating range within 50 ms.
- (8) The POR time for Fast POR ranges between 3 and 9 ms. V<sub>CCINT</sub>, V<sub>CCA</sub>, and V<sub>CCIO</sub> of I/O Banks 3, 8, and 9 must reach the recommended operating range within 3 ms.

# **ESD** Performance

This section lists the electrostatic discharge (ESD) voltages using the human body model (HBM) and charged device model (CDM) for Cyclone IV devices general purpose I/Os (GPIOs) and high-speed serial interface (HSSI) I/Os. Table 1–5 lists the ESD for Cyclone IV devices GPIOs and HSSI I/Os.

Table 1–5. ESD for Cyclone IV Devices GPIOs and HSSI I/0
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Symbol	Parameter	Passing Voltage	Unit
M	ESD voltage using the HBM (GPIOs) <sup>(1)</sup>	± 2000	V
VESDHBM	ESD using the HBM (HSSI I/Os) <sup>(2)</sup>	± 1000	V
V	ESD using the CDM (GPIOs)	± 500	V
VESDCDM	ESD using the CDM (HSSI I/Os) <sup>(2)</sup>	± 250	V

#### Notes to Table 1-5:

(1) The passing voltage for EP4CGX15 and EP4CGX30 row I/Os is ±1000V.

(2) This value is applicable only to Cyclone IV GX devices.

							V <sub>ccio</sub>	(V)						
Parameter	Condition	1	.2	1	.5	1	.8	2	.5	3	.0	3	.3	Unit
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	
Bus hold trip point	—	0.3	0.9	0.375	1.125	0.68	1.07	0.7	1.7	0.8	2	0.8	2	V

Table 1–7. Bus Hold Parameter for Cyclone IV Devices (Part 2 of 2)<sup>(1)</sup>

Note to Table 1-7:

(1) Bus hold trip points are based on the calculated input voltages from the JEDEC standard.

## **OCT Specifications**

Table 1–8 lists the variation of OCT without calibration across process, temperature, and voltage (PVT).

		Resistance		
Description	Commercial Maximum ind		Industrial, Extended industrial, and Automotive Maximum	Unit
	3.0	±30	±40	%
Series OCT without calibration	2.5	±30	±40	%
	1.8	±40	±50	%
	1.5	±50	±50	%
	1.2	±50	±50	%

OCT calibration is automatically performed at device power-up for OCT-enabled I/Os.

Table 1–9 lists the OCT calibration accuracy at device power-up.

		Calibratio		
Description	V <sub>CCIO</sub> (V)	Commercial Maximum	Industrial, Extended industrial, and Automotive Maximum	Unit
	3.0	±10	±10	%
Series OCT with calibration at device power-up	2.5	±10	±10	%
	1.8	±10	±10	%
	1.5	±10	±10	%
	1.2	±10	±10	%

Example 1–1 shows how to calculate the change of 50- $\Omega$  I/O impedance from 25°C at 3.0 V to 85°C at 3.15 V.

#### Example 1–1. Impedance Change

$$\begin{split} \Delta R_V &= (3.15-3) \times 1000 \times -0.026 = -3.83 \\ \Delta R_T &= (85-25) \times 0.262 = 15.72 \\ \text{Because } \Delta R_V \text{ is negative,} \\ MF_V &= 1 \ / \ (3.83/100 + 1) = 0.963 \\ \text{Because } \Delta R_T \text{ is positive,} \\ MF_T &= 15.72/100 + 1 = 1.157 \\ MF &= 0.963 \times 1.157 = 1.114 \\ R_{\text{final}} &= 50 \times 1.114 = 55.71 \ \Omega \end{split}$$

# **Pin Capacitance**

Table 1–11 lists the pin capacitance for Cyclone IV devices.

Symbol	Parameter	Typical – Quad Flat Pack (QFP)	Typical – Quad Flat No Leads (QFN)	Typical – Ball-Grid Array (BGA)	Unit
C <sub>IOTB</sub>	Input capacitance on top and bottom I/O pins	7	7	6	pF
C <sub>IOLR</sub>	Input capacitance on right I/O pins	7	7	5	pF
$C_{LVDSLR}$	Input capacitance on right I/O pins with dedicated LVDS output	8	8	7	pF
C <sub>VREFLR</sub>	Input capacitance on right dual-purpose ${\tt VREF}$ pin when used as $V_{\sf REF}$ or user I/O pin	21	21	21	pF
C <sub>VREFTB</sub>	Input capacitance on top and bottom dual-purpose ${\tt VREF}$ pin when used as $V_{\sf REF}$ or user I/O pin	23 <i>(3)</i>	23	23	pF
C <sub>CLKTB</sub>	Input capacitance on top and bottom dedicated clock input pins	7	7	6	pF
C <sub>CLKLR</sub>	Input capacitance on right dedicated clock input pins	6	6	5	pF

Notes to Table 1-11:

(1) The pin capacitance applies to FBGA, UBGA, and MBGA packages.

(2) When you use the vref pin as a regular input or output, you can expect a reduced performance of toggle rate and  $t_{CO}$  because of higher pin capacitance.

(3)  $C_{\text{VREFTB}}$  for the EP4CE22 device is 30 pF.

1/0 Ober devid		V <sub>CCIO</sub> (V)		V <sub>ID</sub> (	(mV)		V <sub>ICM</sub> (V) <sup>(2)</sup>		Vo	<sub>D</sub> (mV)	(3)	V <sub>0S</sub> (V) <sup>(3)</sup>			
I/O Standard	Min	Тур	Max	Min	Max	Min	Condition	Max	Min	Тур	Max	Min	Тур	Max	
						0.05	$D_{MAX} \leq ~500~Mbps$	1.80							
LVDS (Column I/Os)	2.375	2.5	2.625	100	_	0.55	$\begin{array}{l} 500 \mbox{ Mbps} \leq D_{MAX} \\ \leq \mbox{ 700 } \mbox{ Mbps} \end{array}$	1.80	247	_	600	1.125	1.25	1.375	
,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,						1.05	1.05 D <sub>MAX</sub> > 700 Mbps 1.55								
BLVDS (Row I/Os) <sup>(4)</sup>	2.375	2.5	2.625	100	_	_	_	_	_	_	_			_	
BLVDS (Column I/Os) <sup>(4)</sup>	2.375	2.5	2.625	100	_	_	_	_	_		_	_	_		
mini-LVDS (Row I/Os) (5)	2.375	2.5	2.625	_	_	_	_	_	300	_	600	1.0	1.2	1.4	
mini-LVDS (Column I/Os) <sup>(5)</sup>	2.375	2.5	2.625	_	_		_	_	300	_	600	1.0	1.2	1.4	
RSDS® (Row I/Os) <sup>(5)</sup>	2.375	2.5	2.625	_	_	_	_	_	100	200	600	0.5	1.2	1.5	
RSDS (Column I/Os) <sup>(5)</sup>	2.375	2.5	2.625	_	_	_	_	_	100	200	600	0.5	1.2	1.5	
PPDS (Row I/Os) <i>(</i> 5)	2.375	2.5	2.625	—	_		—		100	200	600	0.5	1.2	1.4	
PPDS (Column I/Os) <sup>(5)</sup>	2.375	2.5	2.625				_		100	200	600	0.5	1.2	1.4	

Table 1-20.	Differential I/O Standard S	pecifications for C	yclone IV Devices <sup>(1)</sup>	(Part 2 of 2)
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#### Notes to Table 1-20:

(1) For an explanation of terms used in Table 1–20, refer to "Glossary" on page 1–37.

(2)  $~V_{IN}$  range: 0 V  $\leq V_{IN} \leq$  1.85 V.

 $(3) \quad R_L \text{ range: } 90 \leq \ R_L \leq \ 110 \ \Omega \, .$ 

(4) There are no fixed  $V_{\rm IN},\,V_{\rm OD},\, and\,V_{\rm OS}$  specifications for BLVDS. They depend on the system topology.

(5) The Mini-LVDS, RSDS, and PPDS standards are only supported at the output pins.

(6) The LVPECL I/O standard is only supported on dedicated clock input pins. This I/O standard is not supported for output pins.

# **Transceiver Performance Specifications**

Table 1–21 lists the Cyclone IV GX transceiver specifications.

#### Table 1–21. Transceiver Specification for Cyclone IV GX Devices (Part 1 of 4)

Symbol/	0 and 111 and		C6			C7, I7			<b>C</b> 8		
Description	Conditions	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
Reference Clock						-		<u>.</u>		<u>.</u>	-
Supported I/O Standards		1.2 V F	PCML, 1.5	V PCML, 3	.3 V PCN	1L, Differe	ntial LVPE	CL, LVD	S, HCSL		
Input frequency from REFCLK input pins	_	50	_	156.25	50	_	156.25	50	_	156.25	MHz
Spread-spectrum modulating clock frequency	Physical interface for PCI Express (PIPE) mode	30	_	33	30	_	33	30	_	33	kHz
Spread-spectrum downspread	PIPE mode	_	0 to 0.5%	_	_	0 to -0.5%	_	_	0 to 0.5%	_	_
Peak-to-peak differential input voltage	_	0.1	_	1.6	0.1	_	1.6	0.1	_	1.6	V
$V_{\text{ICM}}$ (AC coupled)	—		1100 ± 5	%		1100 ± 59	%		1100 ± 5	%	mV
$V_{\text{ICM}}$ (DC coupled)	HCSL I/O standard for PCIe reference clock	250	_	550	250	_	550	250	_	550	mV
Transmitter REFCLK Phase Noise <sup>(1)</sup>	Frequency offset		_	-123	_	_	-123	_	_	-123	dBc/Hz
Transmitter REFCLK Total Jitter <sup>(1)</sup>	= 1 MHz – 8 MHZ		_	42.3	_	_	42.3	_	_	42.3	ps
R <sub>ref</sub>			2000 ± 1%		_	2000 ± 1%	_	_	2000 ± 1%	_	Ω
Transceiver Clock											
cal_blk_clk clock frequency	_	10	_	125	10	_	125	10	_	125	MHz
fixedclk clock frequency	PCIe Receiver Detect	_	125	_	_	125	_	_	125	—	MHz
reconfig_clk clock frequency	Dynamic reconfiguration clock frequency	2.5/ 37.5 <i>(2)</i>	_	50	2.5/ 37.5 <i>(2)</i>	_	50	2.5/ 37.5 <i>(2)</i>	_	50	MHz
Delta time between reconfig_clk	_	_	_	2	_	_	2	_	_	2	ms
Transceiver block minimum power-down pulse width	_	_	1		_	1	_	_	1	—	μs

Symbol/	Ocaditions		<b>C6</b>			C7, I7			<b>C</b> 8		11
Description	Conditions	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
Receiver					•	•		•	•		
Supported I/O Standards	1.4 V PCML, 1.5 V PCML, 2.5 V PCML, LVPECL, LVDS										
Data rate (F324 and smaller package) <sup>(15)</sup>	_	600	_	2500	600	_	2500	600	_	2500	Mbps
Data rate (F484 and larger package) <sup>(15)</sup>			_	3125	600	_	3125	600	_	2500	Mbps
Absolute V <sub>MAX</sub> for a receiver pin <i>(3)</i>	—	_	_	1.6	_	_	1.6	_	_	1.6	V
Operational V <sub>MAX</sub> for a receiver pin	—	_	_	1.5	_	_	1.5	_	_	1.5	V
Absolute V <sub>MIN</sub> for a receiver pin	_	-0.4	_	_	-0.4	_	_	-0.4	_	_	V
Peak-to-peak differential input voltage V <sub>ID</sub> (diff p-p)	V <sub>ICM</sub> = 0.82 V setting, Data Rate = 600 Mbps to 3.125 Gbps	0.1	_	2.7	0.1	_	2.7	0.1	_	2.7	V
V <sub>ICM</sub>	V <sub>ICM</sub> = 0.82 V setting	_	820 ± 10%	_	_	820 ± 10%	_	_	820 ± 10%	_	mV
Differential on-chip	100– $\Omega$ setting		100	—	_	100		_	100	—	Ω
termination resistors	150– $\Omega$ setting	_	150	_	_	150		_	150	—	Ω
Differential and common mode return loss	PIPE, Serial Rapid I/O SR, SATA, CPRI LV, SDI, XAUI					Compliant	Ľ				_
Programmable ppm detector <sup>(4)</sup>	_				± 62.5	, 100, 128 250, 300					ppm
Clock data recovery (CDR) ppm tolerance (without spread-spectrum clocking enabled)				±300 <i>(5)</i> , ±350 <i>(6)</i> , <i>(7)</i>			±300 (5), ±350 (6), (7)		_	±300 (5), ±350 (6), (7)	ppm
CDR ppm tolerance (with synchronous spread-spectrum clocking enabled) <sup>(8)</sup>	_	_		350 to 5350 (7), (9)	_		350 to 5350 (7), (9)	_		350 to 5350 (7), (9)	ppm
Run length	—		80		—	80	_	—	80		UI
	No Equalization		—	1.5	—	_	1.5	—	_	1.5	dB
Programmable	Medium Low		_	4.5	_	_	4.5	_		4.5	dB
equalization	Medium High		_	5.5	—	_	5.5	—	_	5.5	dB
	High	<b>—</b>		7	-	_	7	-	_	7	dB

Table 1–21.	Transceiver S	necification fo	r Cyclone	IV GX Devices	(Part 2 of 4)
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#### Table 1–21. Transceiver Specification for Cyclone IV GX Devices (Part 4 of 4)

Symbol/	Conditions	C6				C7, 17			<b>C</b> 8		Unit			
Description	Conultions	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	UIIIL			
PLD-Transceiver Interface														
Interface speed (F324 and smaller package)	_	25	_	125	25	_	125	25	_	125	MHz			
Interface speed (F484 and larger package)	_	25	_	156.25	25	_	156.25	25	_	156.25	MHz			
Digital reset pulse width	_		Minimum is 2 parallel clock cycles											

#### Notes to Table 1–21:

(1) This specification is valid for transmitter output jitter specification with a maximum total jitter value of 112 ps, typically for 3.125 Gbps SRIO and XAUI protocols.

(2) The minimum reconfig\_clk frequency is 2.5 MHz if the transceiver channel is configured in **Transmitter Only** mode. The minimum reconfig\_clk frequency is 37.5 MHz if the transceiver channel is configured in **Receiver Only** or **Receiver and Transmitter** mode.

- (3) The device cannot tolerate prolonged operation at this absolute maximum.
- (4) The rate matcher supports only up to ±300 parts per million (ppm).
- (5) Supported for the F169 and F324 device packages only.
- (6) Supported for the F484, F672, and F896 device packages only. Pending device characterization.
- (7) To support CDR ppm tolerance greater than ±300 ppm, implement ppm detector in user logic and configure CDR to Manual Lock Mode.
- (8) Asynchronous spread-spectrum clocking is not supported.
- (9) For the EP4CGX30 (F484 package only), EP4CGX50, and EP4CGX75 devices, the CDR ppl tolerance is ±200 ppm.
- (10) Time taken until pll\_locked goes high after pll\_powerdown deasserts.
- (11) Time that the CDR must be kept in lock-to-reference mode after rx\_analogreset deasserts and before rx\_locktodata is asserted in manual mode.

(12) Time taken to recover valid data after the rx\_locktodata signal is asserted in manual mode (Figure 1–2), or after rx\_freqlocked signal goes high in automatic mode (Figure 1–3).

(13) Time taken to recover valid data after the rx\_locktodata signal is asserted in manual mode.

- (14) Time taken to recover valid data after the  $rx\_freqlocked$  signal goes high in automatic mode.
- (15) To support data rates lower than the minimum specification through oversampling, use the CDR in LTR mode only.

Figure 1–2 shows the lock time parameters in manual mode.

LTD = lock-to-data. LTR = lock-to-reference.

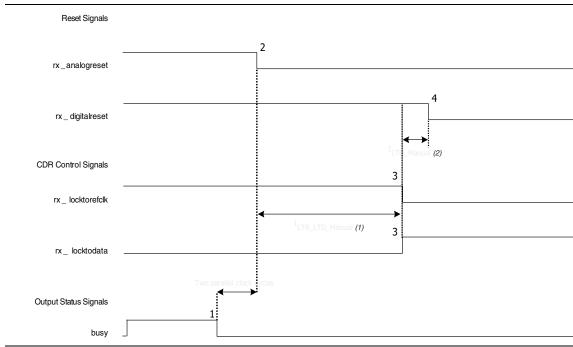
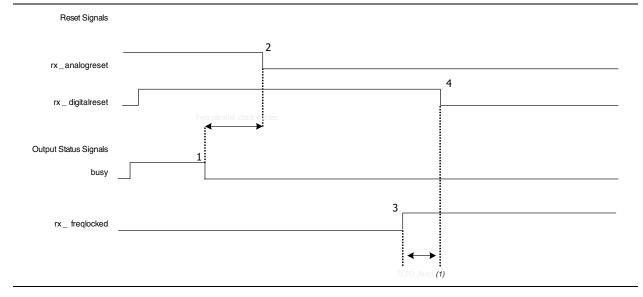
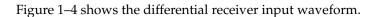


Figure 1–2. Lock Time Parameters for Manual Mode

Figure 1–3 shows the lock time parameters in automatic mode.

Figure 1–3. Lock Time Parameters for Automatic Mode







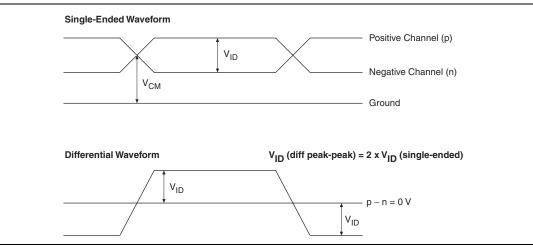


Figure 1–5 shows the transmitter output waveform.



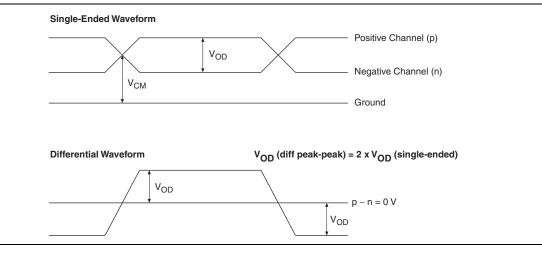


Table 1–22 lists the typical  $V_{OD}$  for Tx term that equals 100  $\Omega$ .

#### Table 1–22. Typical V\_{0D} Setting, Tx Term = 100 $\Omega$

Symbol		V <sub>OD</sub> Setting (mV)												
	1	2	3	<b>4</b> (1)	5	6								
V <sub>OD</sub> differential peak to peak typical (mV)	400	600	800	900	1000	1200								

#### Note to Table 1-22:

(1) This setting is required for compliance with the PCIe protocol.

Table 1–23 lists the Cyclone IV GX transceiver block AC specifications.

Symbol/	0		C6			C7, 17	7		<b>C</b> 8		
Description	Conditions	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
PCIe Transmit Jitter Gene	ration <sup>(3)</sup>	-		<u>.</u>	-		<u>.</u>			<u>.</u>	
Total jitter at 2.5 Gbps (Gen1)	Compliance pattern	_	_	0.25	_	_	0.25	_	_	0.25	UI
PCIe Receiver Jitter Toler	ance <sup>(3)</sup>	•						•	•		•
Total jitter at 2.5 Gbps (Gen1)	Compliance pattern	> 0.6			> 0.6			> 0.6			UI
GIGE Transmit Jitter Gene	ration <sup>(4)</sup>	•						•			•
Deterministic jitter	Pattern = CRPAT			0.14			0.14			0.14	UI
(peak-to-peak)	Falleni = UNFAI			0.14		_	0.14	_		0.14	01
Total jitter (peak-to-peak)	Pattern = CRPAT	—		0.279	_		0.279	_		0.279	UI
GIGE Receiver Jitter Toler	ance <sup>(4)</sup>										
Deterministic jitter tolerance (peak-to-peak)	Pattern = CJPAT	> 0.4		> 0.4				> 0.4		UI	
Combined deterministic and random jitter tolerance (peak-to-peak)	Pattern = CJPAT	> 0.66			> 0.66				6	UI	

#### Table 1–23. Transceiver Block AC Specification for Cyclone IV GX Devices (1), (2)

Notes to Table 1-23:

(1) Dedicated refclk pins were used to drive the input reference clocks.

(2) The jitter numbers specified are valid for the stated conditions only.

(3) The jitter numbers for PIPE are compliant to the PCIe Base Specification 2.0.

(4) The jitter numbers for GIGE are compliant to the IEEE802.3-2002 Specification.

# **Core Performance Specifications**

The following sections describe the clock tree specifications, PLLs, embedded multiplier, memory block, and configuration specifications for Cyclone IV Devices.

## **Clock Tree Specifications**

Table 1–24 lists the clock tree specifications for Cyclone IV devices.

 Table 1–24. Clock Tree Performance for Cyclone IV Devices (Part 1 of 2)

Device		Performance													
Device	C6	C7	C8	C8L <sup>(1)</sup>	C9L <sup>(1)</sup>	17	18L <sup>(1)</sup>	A7	Unit						
EP4CE6	500	437.5	402	362	265	437.5	362	402	MHz						
EP4CE10	500	437.5	402	362	265	437.5	362	402	MHz						
EP4CE15	500	437.5	402	362	265	437.5	362	402	MHz						
EP4CE22	500	437.5	402	362	265	437.5	362	402	MHz						
EP4CE30	500	437.5	402	362	265	437.5	362	402	MHz						
EP4CE40	500	437.5	402	362	265	437.5	362	402	MHz						

Symbol Modes	aeboM	C6				C7, I7 C8, A7					C8L, 18L			C9L			Unit
	WOUCS	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
t <sub>LOCK</sub> (3)				1	—	—	1		_	1		—	1			1	ms

#### Table 1–31. RSDS Transmitter Timing Specifications for Cyclone IV Devices <sup>(1), (2), (4)</sup> (Part 2 of 2)

Notes to Table 1-31:

(1) Applicable for true RSDS and emulated RSDS\_E\_3R transmitter.

(2) Cyclone IV E devices—true RSDS transmitter is only supported at the output pin of Row I/O Banks 1, 2, 5, and 6. Emulated RSDS transmitter is supported at the output pin of all I/O Banks. Cyclone IV GX devices—true RSDS transmitter is only supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is only supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is only supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is only supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is only supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is only supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is only supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is only supported at the output pin of Row I/O Banks 5 and 6. Emulated RSDS transmitter is only supported at the

pin of I/O Banks 3, 4, 5, 6, 7, 8, and 9.
(3) t<sub>LOCK</sub> is the time required for the PLL to lock from the end-of-device configuration.

(4) Cyclone IV E 1.0 V core voltage devices only support C8L, C9L, and I8L speed grades. Cyclone IV E 1.2 V core voltage devices only support C6, C7, C8, I7, and A7 speed grades. Cyclone IV GX devices only support C6, C7, C8, and I7 speed grades.

Symbol	Modes		C6			C7, 17	,	C8, A7			(	C8L, 18	SL	C9L			Unit
Symbol Modes		Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	UNIT
	×10	5	—	85	5	—	85	5		85	5		85	5	—	72.5	MHz
	×8	5		85	5		85	5	-	85	5	_	85	5	—	72.5	MHz
f <sub>HSCLK</sub> (input clock	×7	5	—	85	5	_	85	5	_	85	5	_	85	5	—	72.5	MHz
frequency)	×4	5		85	5		85	5	_	85	5	_	85	5	—	72.5	MHz
,	×2	5	_	85	5	_	85	5		85	5		85	5	_	72.5	MHz
	×1	5	_	170	5	_	170	5	_	170	5	_	170	5	—	145	MHz
	×10	100		170	100		170	100	_	170	100	_	170	100	—	145	Mbps
	×8	80	—	170	80		170	80	_	170	80	_	170	80	—	145	Mbps
Device operation in	×7	70	—	170	70		170	70	_	170	70	_	170	70	—	145	Mbps
Mbps	×4	40	—	170	40	_	170	40	_	170	40	_	170	40	—	145	Mbps
	×2	20	_	170	20		170	20	_	170	20	_	170	20	—	145	Mbps
	×1	10	_	170	10	_	170	10	_	170	10	_	170	10	—	145	Mbps
t <sub>DUTY</sub>	—	45	_	55	45	-	55	45	_	55	45	_	55	45	—	55	%
TCCS	—	—	_	200	_		200	_	_	200	_	_	200	_	—	200	ps
Output jitter (peak to peak)	_	_	_	500	_	_	500	_	_	550	_	_	600	_		700	ps
	20-80%,																
t <sub>RISE</sub>	C <sub>LOAD</sub> = 5 pF	-	500		_	500		_	500		_	500		_	500	—	ps
t <sub>FALL</sub>	20 - 80%, C <sub>LOAD</sub> =	_	500	_	_	500	_	_	500	_	_	500	_	_	500		ps
	5 pF																

Table 1–32. Emulated RSDS\_E\_1R Transmitter Timing Specifications for Cyclone IV Devices <sup>(1), (3)</sup> (Part 1 of 2)

• For more information about the supported maximum clock rate, device and pin planning, IP implementation, and device termination, refer to *Section III: System Performance Specifications* of the *External Memory Interface Handbook*.

Table 1–37 lists the memory output clock jitter specifications for Cyclone IV devices.

Table 1–37. Memory Output Clock Jitter Specifications for Cyclone IV Devices (1), (2)

Parameter	Symbol	Min	Max	Unit
Clock period jitter	t <sub>JIT(per)</sub>	-125	125	ps
Cycle-to-cycle period jitter	t <sub>JIT(cc)</sub>	-200	200	ps
Duty cycle jitter	t <sub>JIT(duty)</sub>	-150	150	ps

#### Notes to Table 1-37:

(1) Memory output clock jitter measurements are for 200 consecutive clock cycles, as specified in the JEDEC DDR2 standard.

(2) The clock jitter specification applies to memory output clock pins generated using DDIO circuits clocked by a PLL output routed on a global clock (GCLK) network.

## **Duty Cycle Distortion Specifications**

Table 1–38 lists the worst case duty cycle distortion for Cyclone IV devices.

Table 1–38. Duty Cycle Distortion on Cyclone IV Devices I/O Pins (1), (2), (3)

Symbol	C6		C7	, 17	C8, I8	BL, A7	C	Unit	
Symbol	Min	Max	Min	Max	Min	Max	Min	Max	Unit
Output Duty Cycle	45	55	45	55	45	55	45	55	%

Notes to Table 1-38:

(1) The duty cycle distortion specification applies to clock outputs from the PLLs, global clock tree, and IOE driving the dedicated and general purpose I/O pins.

(2) Cyclone IV devices meet the specified duty cycle distortion at the maximum output toggle rate for each combination of I/O standard and current strength.

(3) Cyclone IV E 1.0 V core voltage devices only support C8L, C9L, and I8L speed grades. Cyclone IV E 1.2 V core voltage devices only support C6, C7, C8, I7, and A7 speed grades. Cyclone IV GX devices only support C6, C7, C8, and I7 speed grades.

## **OCT Calibration Timing Specification**

Table 1–39 lists the duration of calibration for series OCT with calibration at device power-up for Cyclone IV devices.

# Table 1–39. Timing Specification for Series OCT with Calibration at Device Power-Up for Cyclone IV Devices $^{(1)}$

Symbol	Description	Maximum	Units	
t <sub>octcal</sub>	Duration of series OCT with calibration at device power-up	20	μs	

#### Note to Table 1-39:

(1) OCT calibration takes place after device configuration and before entering user mode.

# **IOE Programmable Delay**

Table 1–40 and Table 1–41 list the IOE programmable delay for Cyclone IV E 1.0 V core voltage devices.

		Number	Min Offset	Max Offset							
Parameter	Paths Affected	of		Fast (	Corner	S	low Corne	er	Unit		
		Setting		C8L	18L	C8L	C9L	18L			
Input delay from pin to internal cells	Pad to I/O dataout to core	7	0	2.054	1.924	3.387	4.017	3.411	ns		
Input delay from pin to input register	Pad to I/O input register	8	0	2.010	1.875	3.341	4.252	3.367	ns		
Delay from output register to output pin	I/O output register to pad	2	0	0.641	0.631	1.111	1.377	1.124	ns		
Input delay from dual-purpose clock pin to fan-out destinations	Pad to global clock network	12	0	0.971	0.931	1.684	2.298	1.684	ns		

Notes to Table 1-40:

(1) The incremental values for the settings are generally linear. For the exact values for each setting, use the latest version of the Quartus II software.

(2) The minimum and maximum offset timing numbers are in reference to setting **0** as available in the Quartus II software.

		Number		Max Offset						
Parameter	Paths Affected	of	Min Offset	Fast (	Corner	S	low Corn	er	Unit	
		Setting		C8L	18L	C8L	C9L	18L		
Input delay from pin to internal cells	Pad to I/O dataout to core	7	0	2.057	1.921	3.389	4.146	3.412	ns	
Input delay from pin to input register	Pad to I/O input register	8	0	2.059	1.919	3.420	4.374	3.441	ns	
Delay from output register to output pin	I/O output register to pad	2	0	0.670	0.623	1.160	1.420	1.168	ns	
Input delay from dual-purpose clock pin to fan-out destinations	Pad to global clock network	12	0	0.960	0.919	1.656	2.258	1.656	ns	

Notes to Table 1-41:

(1) The incremental values for the settings are generally linear. For the exact values for each setting, use the latest version of the Quartus II software.

(2) The minimum and maximum offset timing numbers are in reference to setting **0** as available in the Quartus II software.

Table 1–42 and Table 1–43 list the IOE programmable delay for Cyclone IV E 1.2 V core voltage devices.

		Number	Min Offset	Max Offset									
Parameter	Paths Affected	of		Fa	ast Corn	er		SI	ow Corn	er		Unit	
		Setting		C6	17	A7	C6	C7	C8	17	A7		
Input delay from pin to internal cells	Pad to I/O dataout to core	7	0	1.314	1.211	1.211	2.177	2.340	2.433	2.388	2.508	ns	
Input delay from pin to input register	Pad to I/O input register	8	0	1.307	1.203	1.203	2.19	2.387	2.540	2.430	2.545	ns	
Delay from output register to output pin	I/O output register to pad	2	0	0.437	0.402	0.402	0.747	0.820	0.880	0.834	0.873	ns	
Input delay from dual-purpose clock pin to fan-out destinations	Pad to global clock network	12	0	0.693	0.665	0.665	1.200	1.379	1.532	1.393	1.441	ns	

Notes to Table 1-42:

(1) The incremental values for the settings are generally linear. For the exact values for each setting, use the latest version of the Quartus II software.

(2) The minimum and maximum offset timing numbers are in reference to setting **0** as available in the Quartus II software.

		Number	Min Offset	Max Offset									
Parameter	Paths Affected	of		Fa	ast Corn	er		SI	ow Corn	er		Unit	
		Setting		C6	17	A7	C6	C7	C8	17	A7		
Input delay from pin to internal cells	Pad to I/O dataout to core	7	0	1.314	1.209	1.209	2.201	2.386	2.510	2.429	2.548	ns	
Input delay from pin to input register	Pad to I/O input register	8	0	1.312	1.207	1.207	2.202	2.402	2.558	2.447	2.557	ns	
Delay from output register to output pin	I/O output register to pad	2	0	0.458	0.419	0.419	0.783	0.861	0.924	0.875	0.915	ns	
Input delay from dual-purpose clock pin to fan-out destinations	Pad to global clock network	12	0	0.686	0.657	0.657	1.185	1.360	1.506	1.376	1.422	ns	

Table 1–43. IOE Programmable Delay on Row Pins for Cyclone IV E 1.2 V Core Voltage Devices (1), (2)

#### Notes to Table 1-43:

(1) The incremental values for the settings are generally linear. For the exact values for each setting, use the latest version of the Quartus II software.

(2) The minimum and maximum offset timing numbers are in reference to setting **0** as available in the Quartus II software.

### Table 1-46. Glossary (Part 3 of 5)

Letter	Term	Definitions
	RL	Receiver differential input discrete resistor (external to Cyclone IV devices).
R	Receiver Input Waveform Receiver input skew margin (RSKM)	Receiver input waveform for LVDS and LVPECL differential standards:         Single-Ended Waveform $V_{ID}$ $V_{CM}$ Positive Channel (p) = $V_{IH}$ Negative Channel (n) = $V_{IL}$ Ground         Differential Waveform (Mathematical Function of Positive & Negative Channel) $V_{ID}$ $V_{ID}$ $V_{ID}$ $V_{ID}$
		High-speed I/O block: The total margin left after accounting for the sampling window and TCCS. RSKM = (TUI – SW – TCCS) / 2.
S	Single-ended voltage- referenced I/O Standard	VCCIO         VOH         VIH(DC)         VIH(DC)         VIL(AC)         Values. The AC values indicate the voltage levels at which the receiver must meet its timing specifications. The DC values indicate the voltage levels at which the final logic state of the receiver is unambiguously defined. After the receiver input crosses the AC value, the receiver changes to the new logic state. The new logic state is then maintained as long as the input stays beyond the DC threshold. This approach is intended to provide predictable receiver timing in the presence of input waveform <i>ringing</i> .
	SW (Sampling Window)	High-speed I/O block: The period of time during which the data must be valid to capture it correctly. The setup and hold times determine the ideal strobe position in the sampling window.

Letter	Term	Definitions			
	t <sub>C</sub>	High-speed receiver and transmitter input and output clock period.			
	Channel-to- channel-skew (TCCS)	High-speed I/O block: The timing difference between the fastest and slowest output edges, including $t_{CO}$ variation and clock skew. The clock is included in the TCCS measurement.			
	t <sub>cin</sub>	Delay from the clock pad to the I/O input register.			
	t <sub>co</sub>	Delay from the clock pad to the I/O output.			
	t <sub>cout</sub>	Delay from the clock pad to the I/O output register.			
	t <sub>DUTY</sub>	High-speed I/O block: Duty cycle on high-speed transmitter output clock.			
	t <sub>FALL</sub>	Signal high-to-low transition time (80–20%).			
	t <sub>H</sub>	Input register hold time.			
	Timing Unit Interval (TUI)	High-speed I/O block: The timing budget allowed for skew, propagation delays, and data sampling window. (TUI = $1/(\text{Receiver Input Clock Frequency Multiplication Factor}) = t_C/w)$ .			
	t <sub>INJITTER</sub>	Period jitter on the PLL clock input.			
	t <sub>outjitter_dedclk</sub>	Period jitter on the dedicated clock output driven by a PLL.			
	t <sub>outjitter_i0</sub>	Period jitter on the general purpose I/O driven by a PLL.			
	t <sub>pllcin</sub>	Delay from the PLL inclk pad to the I/O input register.			
т	t <sub>plicout</sub>	Delay from the PLL inclk pad to the I/O output register.			
	Transmitter Output Waveform	Transmitter output waveforms for the LVDS, mini-LVDS, PPDS and RSDS Differential I/O Standards: Single-Ended Waveform $V_{OD}$ $V_{$			
	t <sub>RISE</sub>	Signal low-to-high transition time (20–80%).			
	t <sub>SU</sub>	Input register setup time.			
U	—	_			

#### Table 1–46. Glossary (Part 4 of 5)

#### Table 1-46. Glossary (Part 5 of 5)

Letter	Term	Definitions
	V <sub>CM(DC)</sub>	DC common mode input voltage.
	V <sub>DIF(AC)</sub>	AC differential input voltage: The minimum AC input differential voltage required for switching.
	V <sub>DIF(DC)</sub>	DC differential input voltage: The minimum DC input differential voltage required for switching.
	V <sub>ICM</sub>	Input common mode voltage: The common mode of the differential signal at the receiver.
	V <sub>ID</sub>	Input differential voltage swing: The difference in voltage between the positive and complementary conductors of a differential transmission at the receiver.
	V <sub>IH</sub>	Voltage input high: The minimum positive voltage applied to the input that is accepted by the device as a logic high.
	V <sub>IH(AC)</sub>	High-level AC input voltage.
	V <sub>IH(DC)</sub>	High-level DC input voltage.
	V <sub>IL</sub>	Voltage input low: The maximum positive voltage applied to the input that is accepted by the device as a logic low.
	V <sub>IL (AC)</sub>	Low-level AC input voltage.
	V <sub>IL (DC)</sub>	Low-level DC input voltage.
	V <sub>IN</sub>	DC input voltage.
	V <sub>OCM</sub>	Output common mode voltage: The common mode of the differential signal at the transmitter.
V	V <sub>OD</sub>	Output differential voltage swing: The difference in voltage between the positive and complementary conductors of a differential transmission at the transmitter. $V_{0D} = V_{0H} - V_{0L}$ .
	V <sub>OH</sub>	Voltage output high: The maximum positive voltage from an output that the device considers is accepted as the minimum positive high level.
	V <sub>OL</sub>	Voltage output low: The maximum positive voltage from an output that the device considers is accepted as the maximum positive low level.
	V <sub>os</sub>	Output offset voltage: $V_{OS} = (V_{OH} + V_{OL}) / 2$ .
	V <sub>OX (AC)</sub>	AC differential output cross point voltage: the voltage at which the differential output signals must cross.
	V <sub>REF</sub>	Reference voltage for the SSTL and HSTL I/O standards.
	V <sub>REF (AC)</sub>	AC input reference voltage for the SSTL and HSTL I/O standards. $V_{REF(AC)} = V_{REF(DC)} + noise$ . The peak-to-peak AC noise on $V_{REF}$ must not exceed 2% of $V_{REF(DC)}$ .
	V <sub>REF (DC)</sub>	DC input reference voltage for the SSTL and HSTL I/O standards.
	V <sub>SWING (AC)</sub>	AC differential input voltage: AC input differential voltage required for switching. For the SSTL differential I/O standard, refer to Input Waveforms.
	V <sub>SWING (DC)</sub>	DC differential input voltage: DC input differential voltage required for switching. For the SSTL differential I/O standard, refer to Input Waveforms.
	V <sub>TT</sub>	Termination voltage for the SSTL and HSTL I/O standards.
	V <sub>X (AC)</sub>	AC differential input cross point voltage: The voltage at which the differential input signals must cross.
W	—	_
X	—	—
Y	—	_
Z	—	_

# **Document Revision History**

Table 1–47 lists the revision history for this chapter.

Date	Version	Changes
March 2016	2.0	Updated note (5) in Table 1–21 to remove support for the N148 package.
Ostobor 2014	1.9	Updated maximum value for V <sub>CCD_PLL</sub> in Table 1–1.
October 2014		Removed extended temperature note in Table 1–3.
December 2013	1.8	Updated Table 1–21 by adding Note (15).
May 2013	1.7	Updated Table 1–15 by adding Note (4).
		■ Updated the maximum value for V <sub>I</sub> , V <sub>CCD_PLL</sub> , V <sub>CCI0</sub> , V <sub>CC_CLKIN</sub> , V <sub>CCH_GXB</sub> , and V <sub>CCA_GXB</sub> Table 1–1.
		■ Updated Table 1–11 and Table 1–22.
October 2012	1.6	<ul> <li>Updated Table 1–21 to include peak-to-peak differential input voltage for the Cyclone IV GX transceiver input reference clock.</li> </ul>
		■ Updated Table 1–29 to include the typical DCLK value.
		<ul> <li>Updated the minimum f<sub>HSCLK</sub> value in Table 1–31, Table 1–32, Table 1–33, Table 1–34, and Table 1–35.</li> </ul>
	1.5	<ul> <li>Updated "Maximum Allowed Overshoot or Undershoot Voltage", "Operating Conditions", and "PLL Specifications" sections.</li> </ul>
November 2011		<ul> <li>Updated Table 1–2, Table 1–3, Table 1–4, Table 1–5, Table 1–8, Table 1–9, Table 1–15, Table 1–18, Table 1–19, and Table 1–21.</li> </ul>
		■ Updated Figure 1–1.
	1.4	<ul> <li>Updated for the Quartus II software version 10.1 release.</li> </ul>
December 2010		■ Updated Table 1–21 and Table 1–25.
		<ul> <li>Minor text edits.</li> </ul>
	1.3	Updated for the Quartus II software version 10.0 release:
		■ Updated Table 1–3, Table 1–4, Table 1–21, Table 1–25, Table 1–28, Table 1–30, Table 1–40, Table 1–41, Table 1–42, Table 1–43, Table 1–44, and Table 1–45.
July 2010		■ Updated Figure 1–2 and Figure 1–3.
		<ul> <li>Removed SW Requirement and TCCS for Cyclone IV Devices tables.</li> </ul>
		<ul> <li>Minor text edits.</li> </ul>
	1.2	Updated to include automotive devices:
		<ul> <li>Updated the "Operating Conditions" and "PLL Specifications" sections.</li> </ul>
March 2010		<ul> <li>Updated Table 1–1, Table 1–8, Table 1–9, Table 1–21, Table 1–26, Table 1–27, Table 1–31, Table 1–32, Table 1–33, Table 1–34, Table 1–35, Table 1–36, Table 1–37, Table 1–38, Table 1–40, Table 1–42, and Table 1–43.</li> </ul>
		<ul> <li>Added Table 1–5 to include ESD for Cyclone IV devices GPIOs and HSSI I/Os.</li> </ul>
		<ul> <li>Added Table 1–44 and Table 1–45 to include IOE programmable delay for Cyclone IV E 1.2 V core voltage devices.</li> </ul>
		<ul> <li>Minor text edits.</li> </ul>